## Application/Control No. Applicant(s)/Patent Under Reexamination 10/664,873 TAMAMURA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Dah-Wei D. Yuan 1745 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 03-2004 US-6,713,201 Bullock et al. 429/12 Α US-В US-С US-D US-Ε US-F US-G US-Н US-. [ US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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